
Challenges Facing the High Temperature Electronics Industry in the Event of Restrictions on High-Pb Solders

Paul T. Vianco

Sandia National Laboratories
Albuquerque, NM
Phone: 505-844-3429
Email: ptvianc@sandia.gov



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Introduction

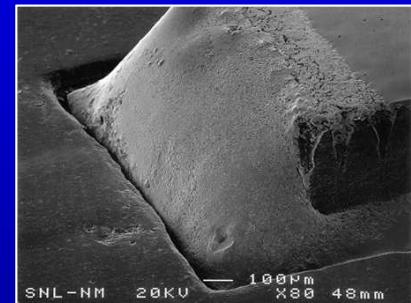
- ◆ The exploration and operation of both renewable (geothermal) and non-renewable (fossil fuel) energy sources will rely heavily upon electronic sensors and down-hole data logging equipment.
 - Cost-effective exploration of new reserves
 - Real-time monitoring of down-hole pressure and temperature conditions.
 - Maximize production
 - Optimize preventive maintenance
 - Prevent inadvertent site shutdowns or worse, environmental damage



Courtesy of NASA

Introduction

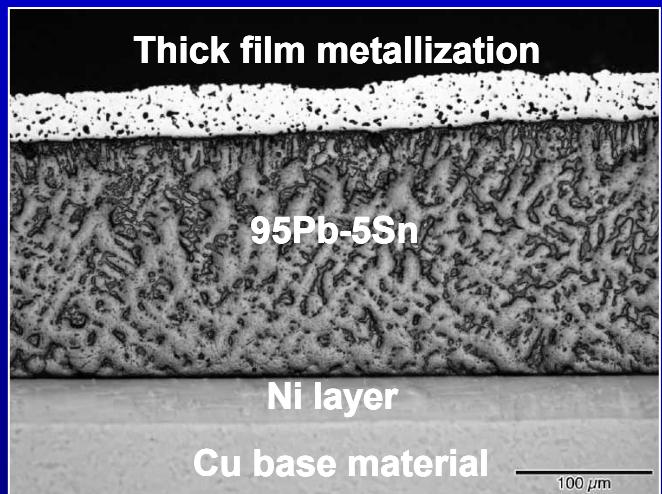
- ◆ **High-lead (Pb) solders, defined as having > 85 wt.% Pb, continue to be used extensively to assemble high-temperature electronics.**
 - **The high-Pb solders remain readily available because of exemption 7a in the RoHS agreement.**
 - **The solidus temperatures provide an adequate margin for service temperatures $\leq 250^{\circ}\text{C}$.**
 - **Excellent fatigue performance:**
 - **Low-cycle, thermal mechanical fatigue**
 - **High-cycle fatigue – vibration**



Introduction

◆ High-lead (Pb) solders ...

- **Satisfactory corrosion resistant in the event of exposure to well environments.**
- **The high-Pb alloys containing 5 – 10 wt.% Sn, In, and Ag are compatible with current assembly infrastructures.**
 - Fluxes
 - Heat sources
 - Surface finishes



“What if ... exemption 7a went away ? “

- ◆ The loss high-Pb solders would pose a challenge for down-hole electronics assemblies.

But ... the challenge is not insurmountable!

- ◆ Alternative interconnection approaches include:

- High temperature filler metals
- Mechanical attachment
- Transient liquid phase (TLP) bonding
- Nanoparticle joining techniques

- ◆ Interconnection material choice(s) must satisfy:

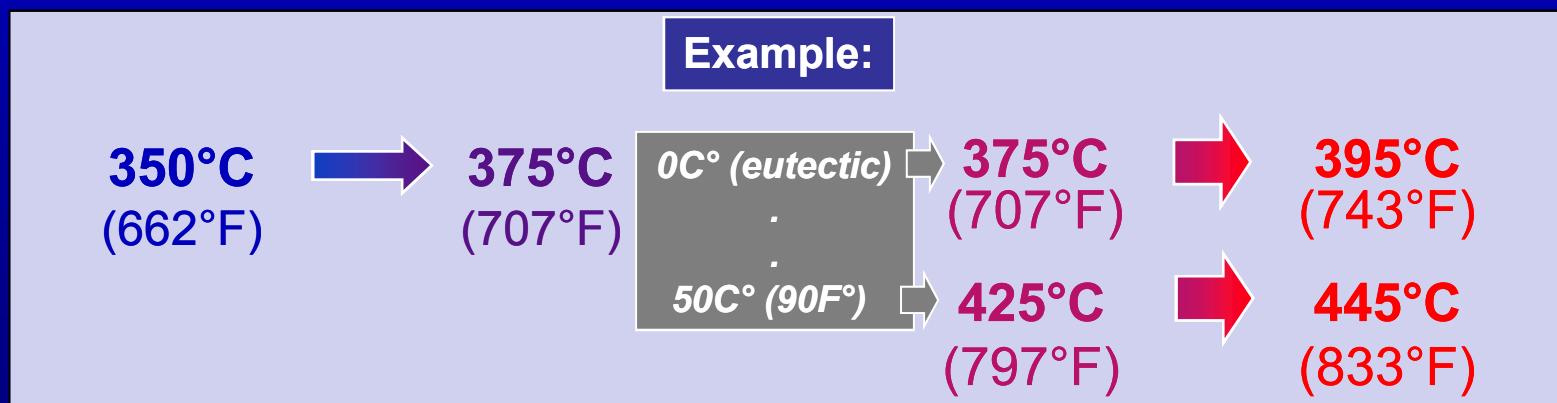
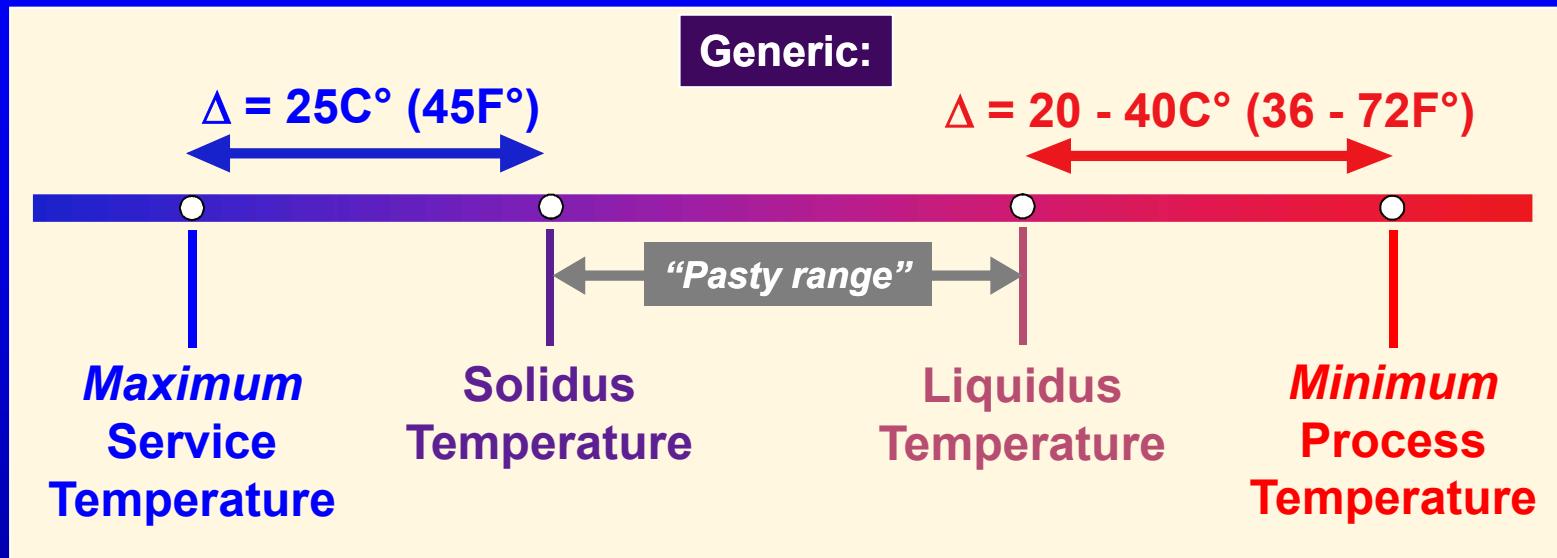
- Assembly processes, infrastructure, and supply chain
- Reliability requirements



Courtesy of Dept. of Energy

High Temperature Filler Metals

- ◆ Solder alloys must be compatible with the *maximum service temperature conditions* and *minimize the process temperature*.



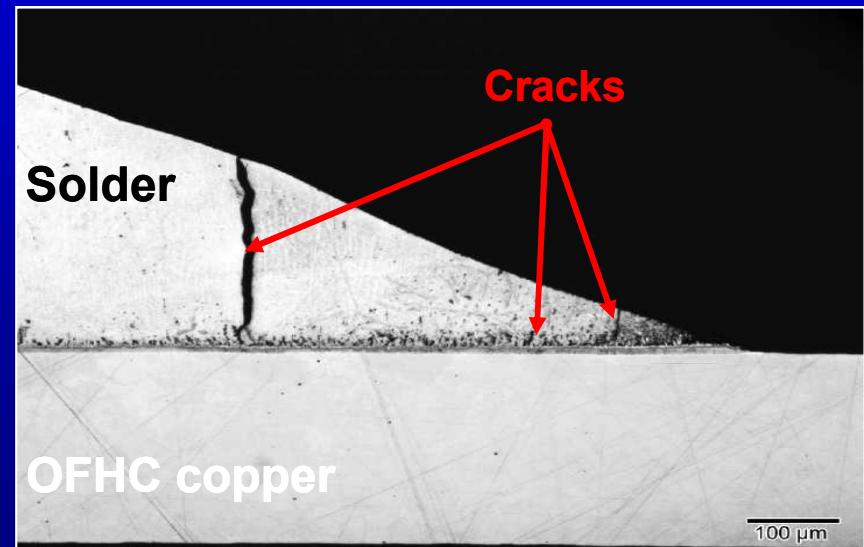
High Temperature Filler Metals

- ◆ There are candidate solder alloys, some commercially-available and others newly engineered, that are being investigated for mechanical properties and solderability performance.
- ◆ Some newly-developed solder alloys are based on zinc (Zn):

100Zn $T_s = T_l = 420^\circ\text{C}$ (788°F)

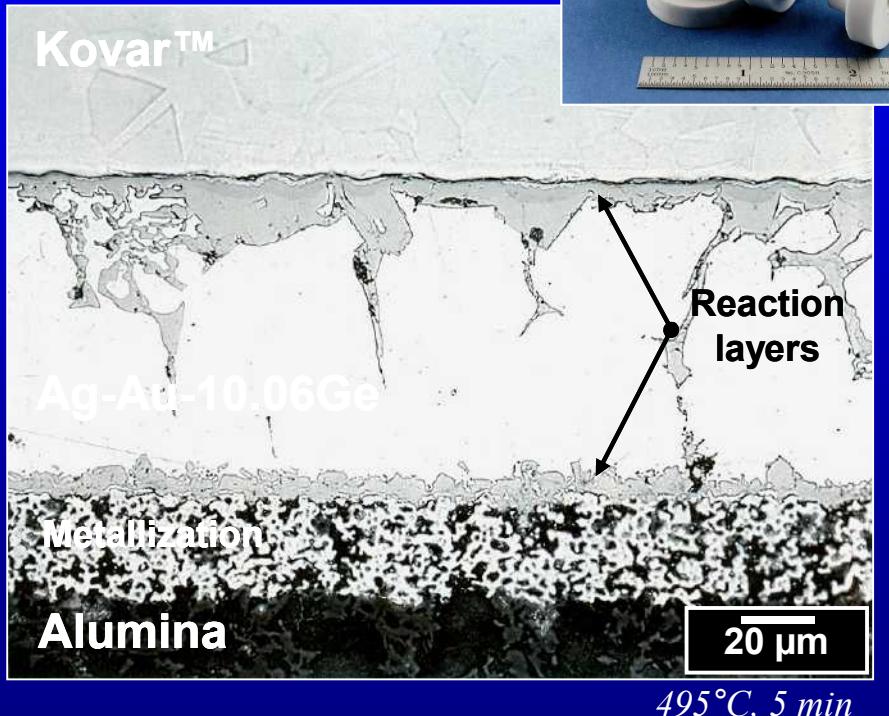
- ◆ At these high process temperatures, controlled atmospheres can replace the flux as the means to reduce surface oxides.

- ◆ Sessile drop experiments provide an initial analysis of the alloy physical metallurgy.

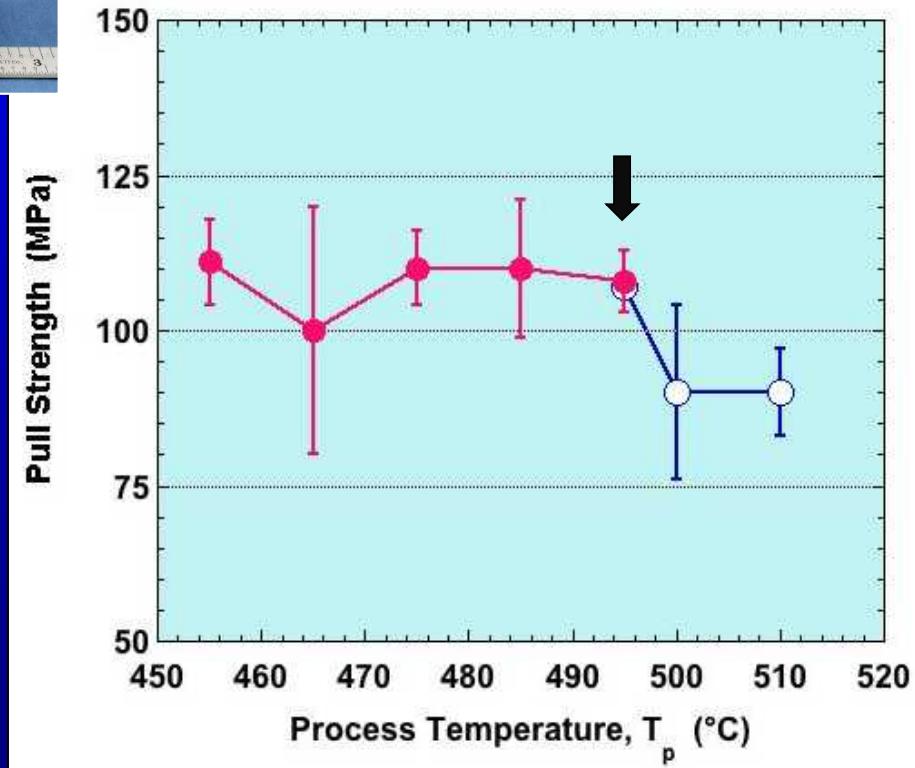


High Temperature Filler Metals

- ◆ The 12.62Ag-77.32Au-10.06Ge (wt.%) alloy (T_s , 400°C to T_l , 450°C) has been considered as a candidate for down-hole applications.

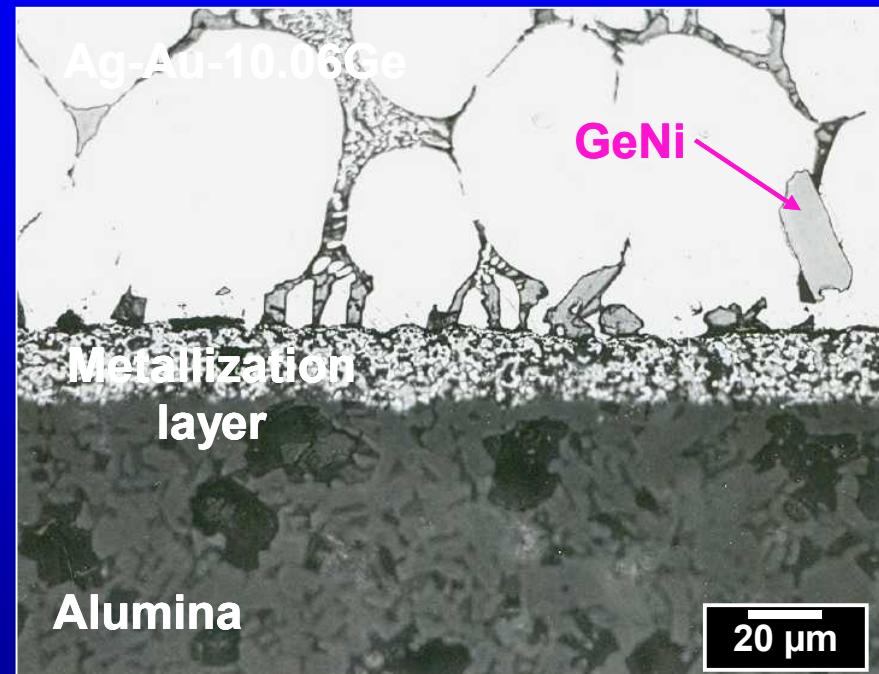
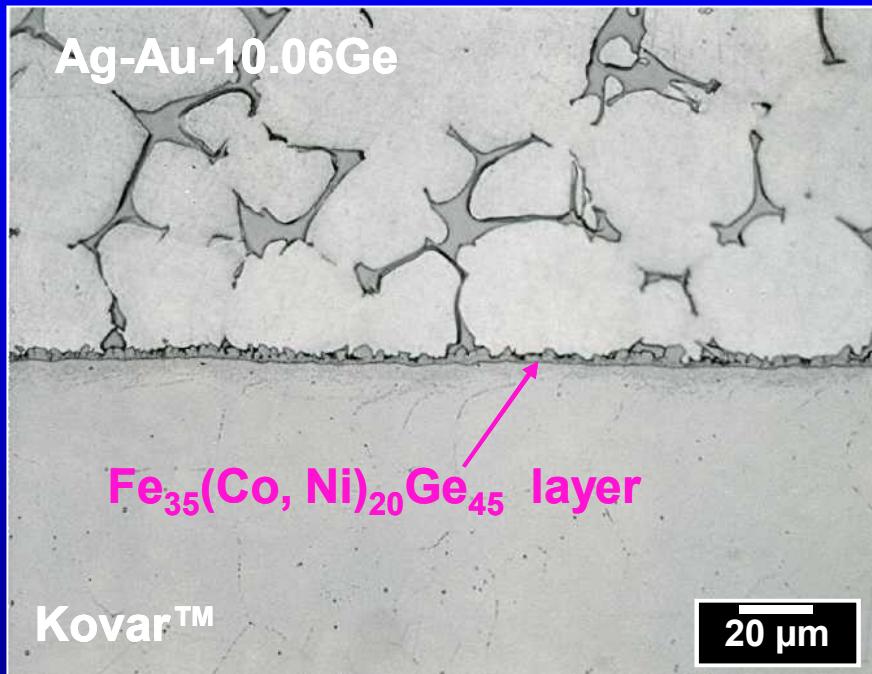


P. Vianco, et al, SMTAI (2013)



High Temperature Filler Metals

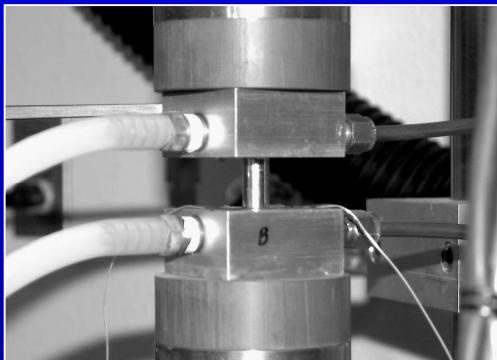
- It is critical to fully understand the **interface microstructures** that develop between high temperature filler metals and the substrate.



- The **Ag-Au-10.06Ge / Kovar interface** is comprised of a 2 – 3 μm reaction layer, $\text{Fe}_{35}(\text{Co, Ni})_{20}\text{Ge}_{45}$ (as determined by EPMA).
- At the **Ag-Au-10.06Ge / ceramic interface**, the Ni layer was often dissolved into the solder, precipitating as **GeNi phase particles**.

High Temperature Filler Metals

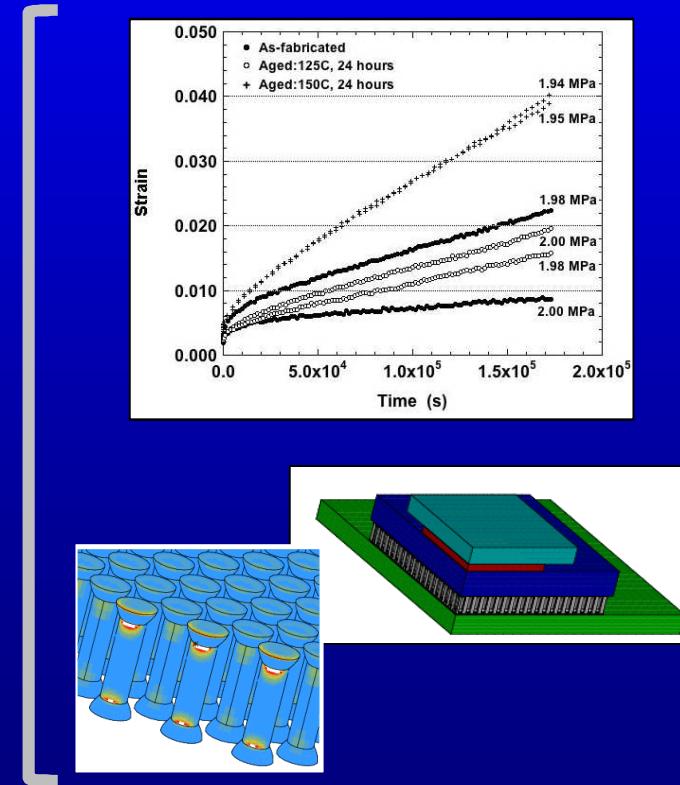
- ◆ High temperature testing will be required in order to obtain both monotonic as well as cyclic (fatigue) mechanical properties for:
 - Screening candidate compositions
 - Input parameters for computational models



Stress-strain tests



Fatigue tests

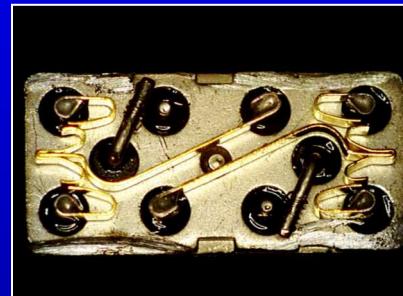


High Temperature Filler Metals

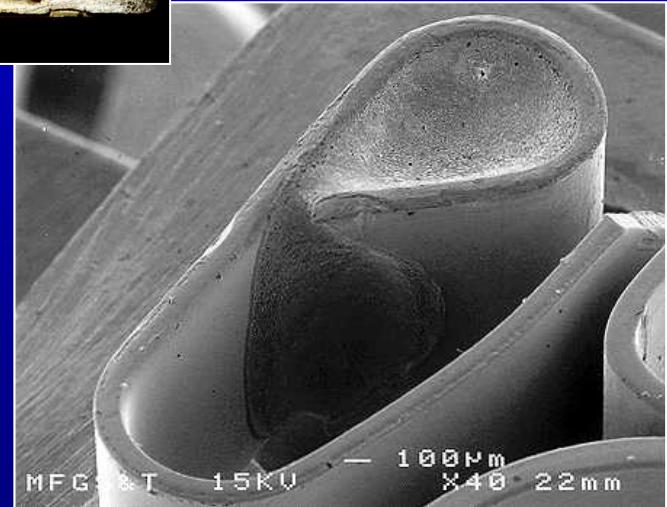
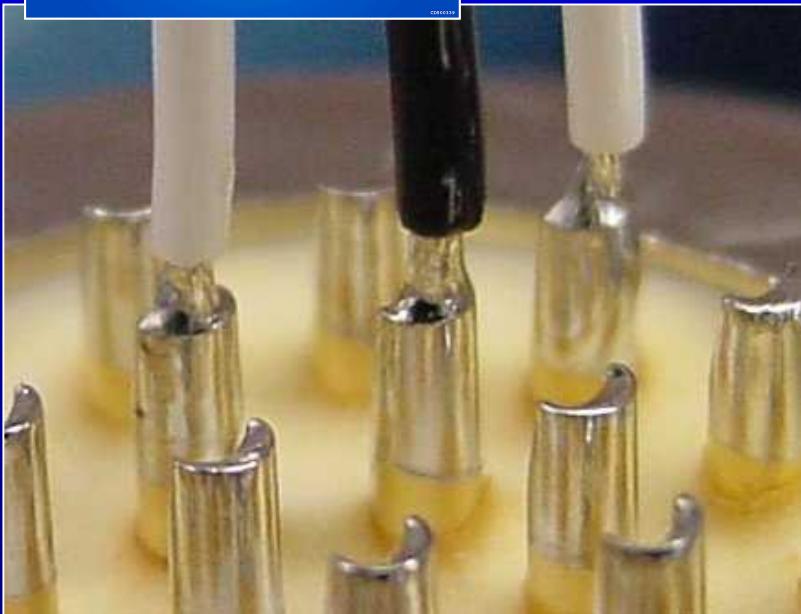
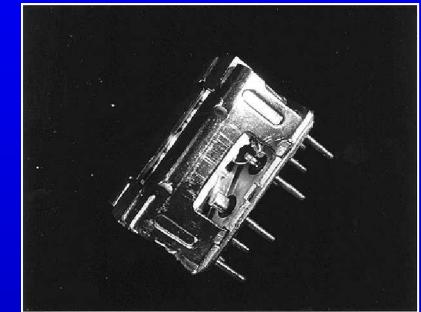
- ◆ New materials sets will be needed for other critical components that include switches, relays, and connectors.



Connector



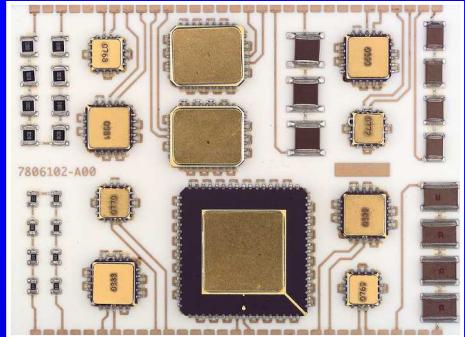
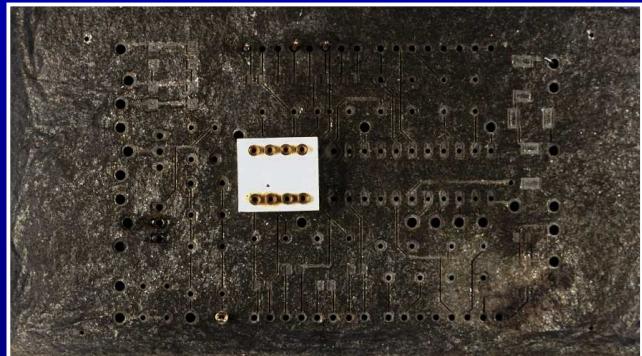
Relay



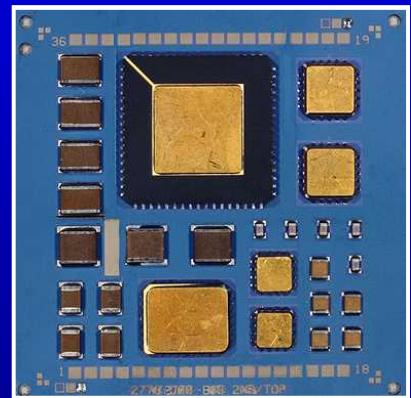
High Temperature Filler Metals

- ◆ Traditional printed circuit board laminates are challenged by the higher temperatures.
- ◆ Ceramic substrates are finding applications:
 - alumina,
 - beryllia,
 - aluminum nitride,
 - low-temperature co-fired ceramic (LTCC).
- ◆ Next-generation substrates include advanced composites and conductors applied by thermal spray or “ink-jet” printing methods.

*Advanced
composites*



Alumina



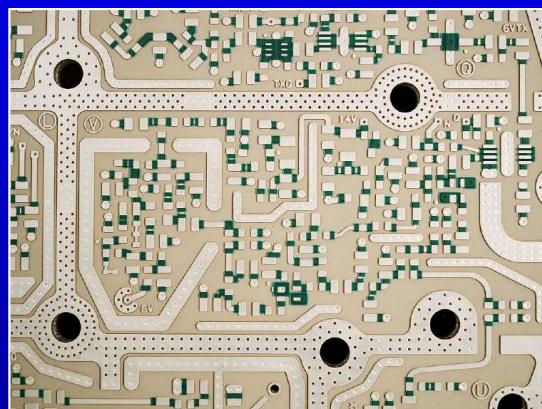
Low-temperature co-fired ceramic (LTCC)

High Temperature Filler Metals

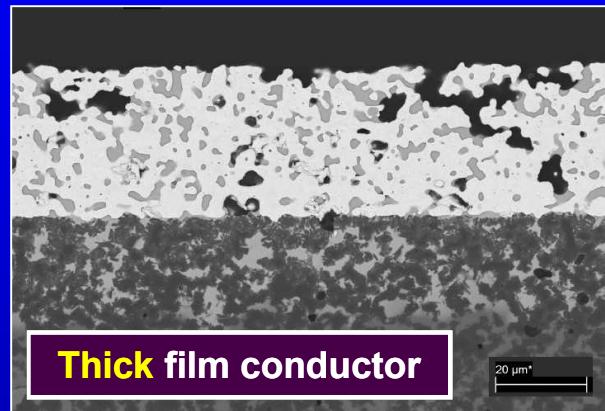
- ◆ **Surface finishes** provide another tool to engineer the solderability of high temperature filler metals on components and substrates.



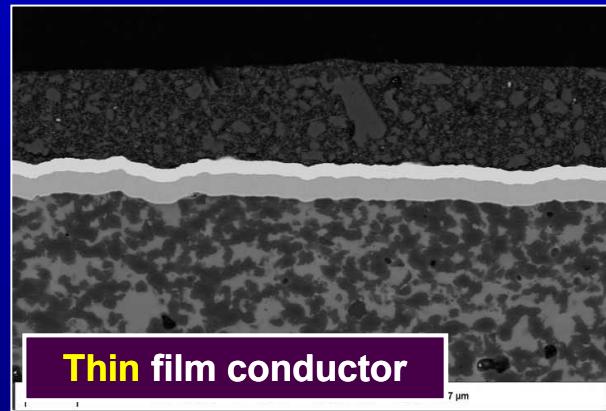
Components



**High-temperature
PCB laminates**



Thick film conductor

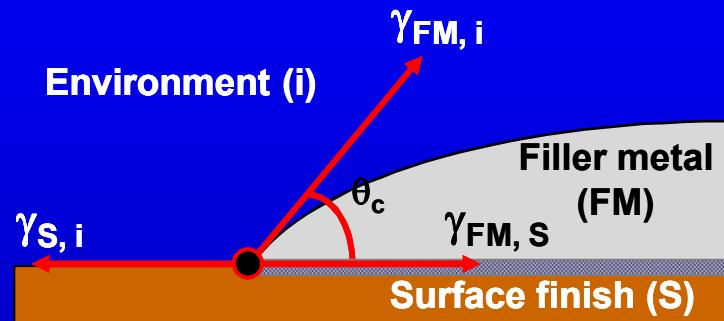


Thin film conductor

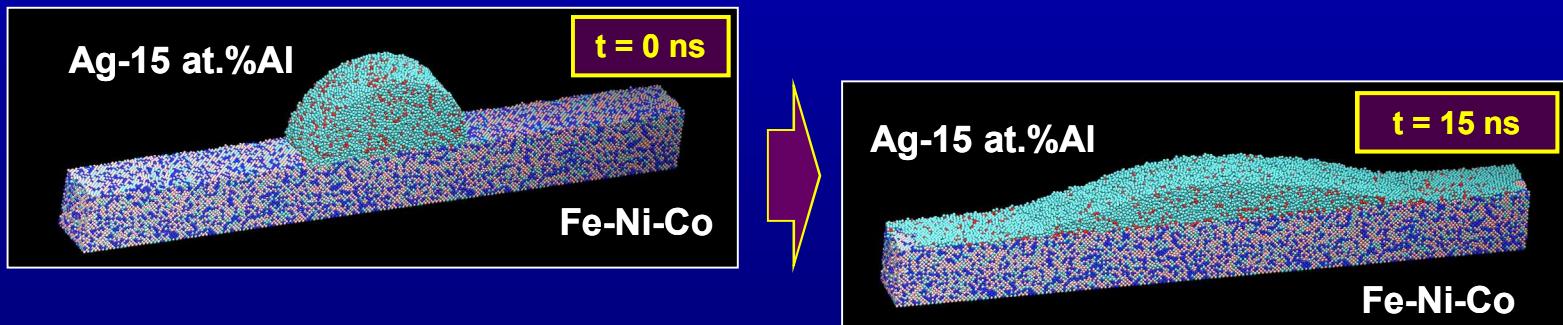
PCB ceramics

High Temperature Filler Metals

- ◆ There is a gap in the understanding of the thermodynamics and rate kinetics of interface reactions relevant to filler metal joining.



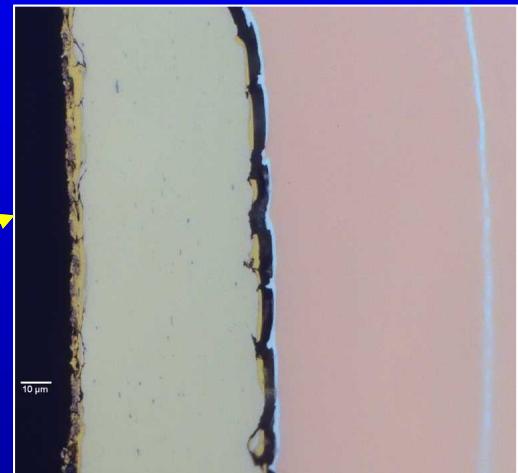
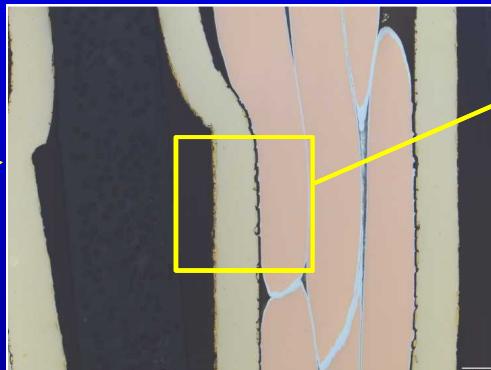
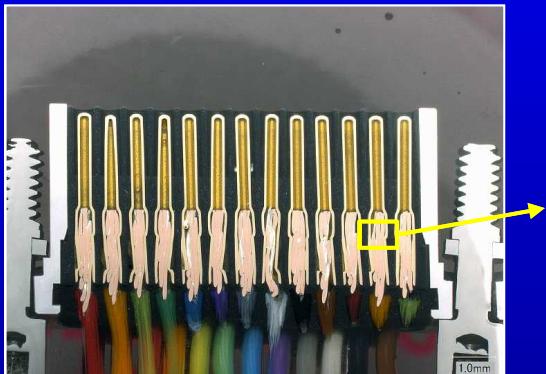
- ◆ Molecular dynamics simulations can provide first-order predictions of wetting-and-spreading and interface reactions between molten filler metals and the solid substrate.



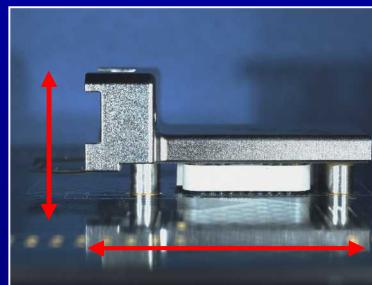
Mechanical Attachments

- ◆ Crimped wires/leads as well as pin-in-socket connections are not preferred for down-hole applications:

- Susceptible to fretting corrosion that increases contact resistance.

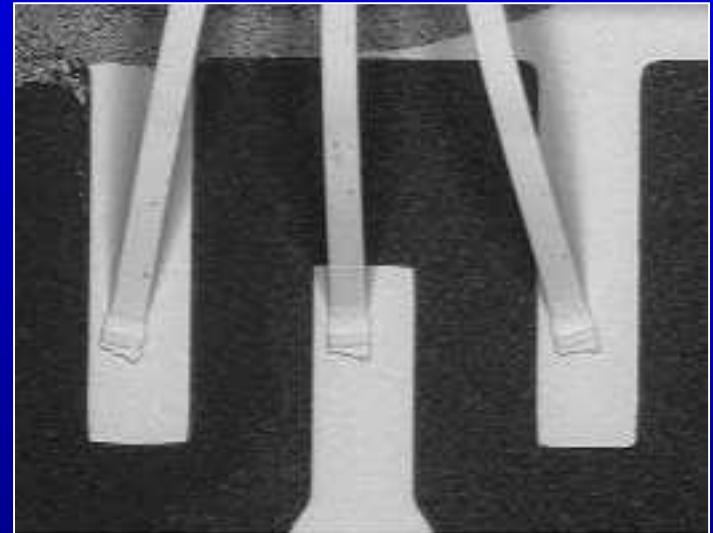


- Sockets and connectors take away miniaturization and increased functionality.



Mechanical Attachments

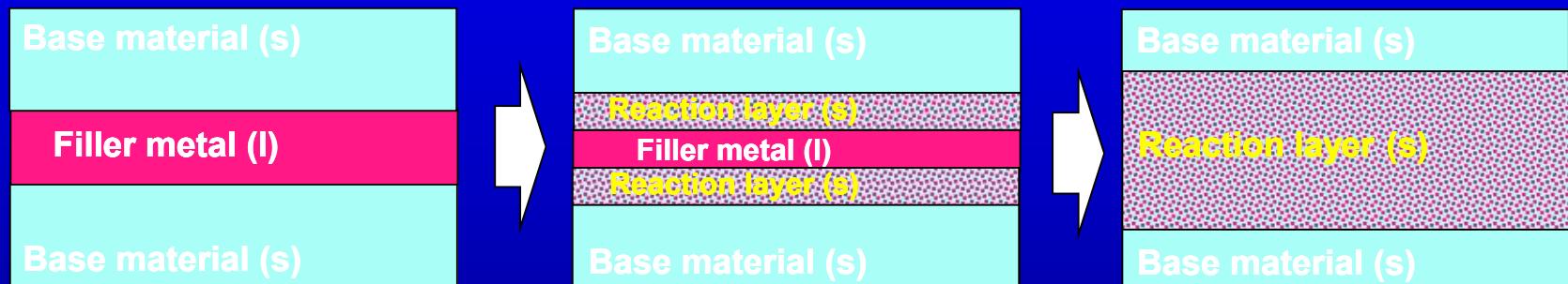
- ◆ On the other hand, thermo-compression and stitch wire and ribbon bonds – both forms of cold-welding – are viable methods:
 - Encapsulations or conformal coatings are recommended to prevent handling and vibration damage.
 - Bond pad and loop height requirements can limit miniaturization.
 - Although not always a consideration in the microelectronics field, an attribute is that these bonds are *reworkable*.



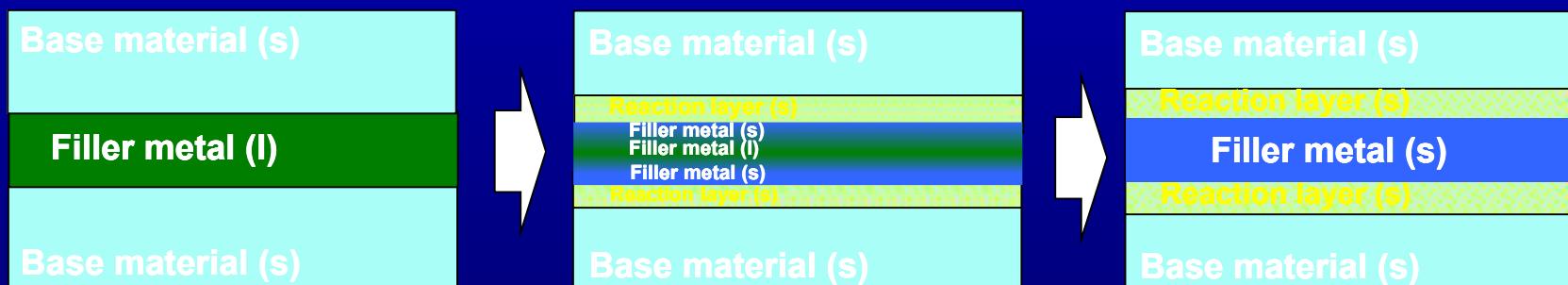
Transient Liquid Phase Bonding (TLP)

- ◆ A methodology that has not received a great deal of attention is transient liquid phase (TLP) bonding:
 - A low temperature process is used to make a higher temperature interconnection.

In-situ TLP

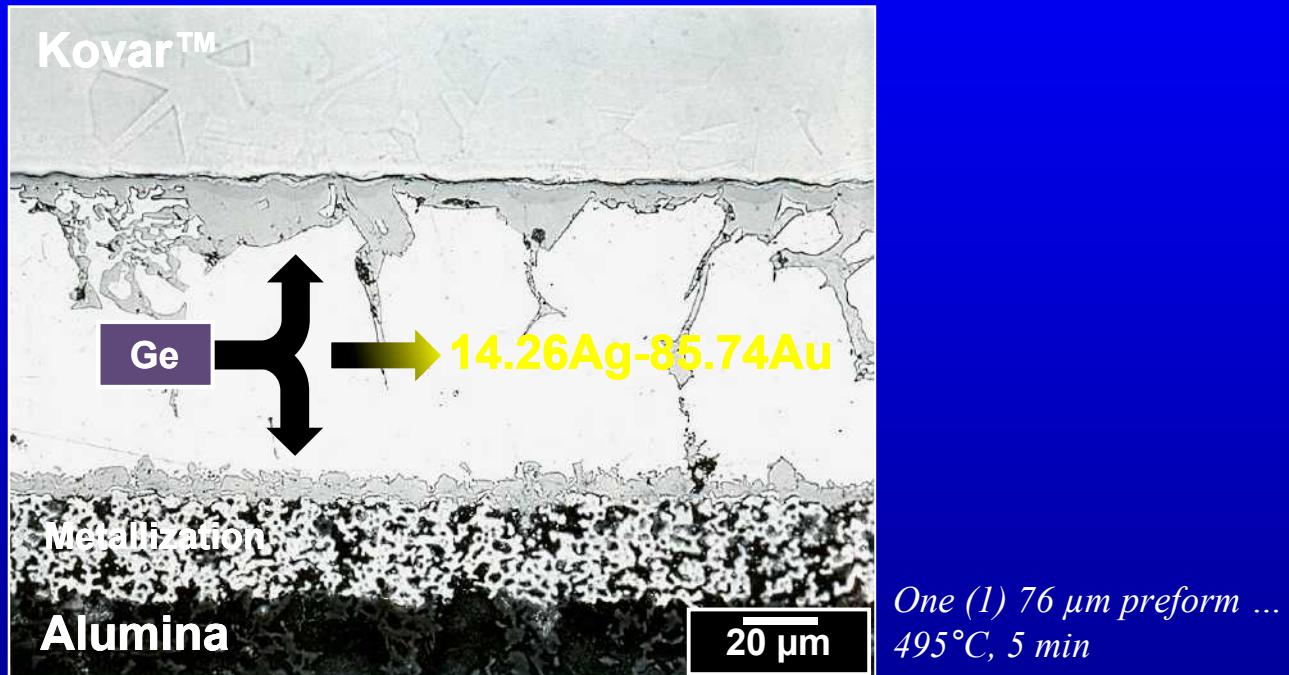


Reverse TLP



Transient Liquid Phase Bonding (TLP)

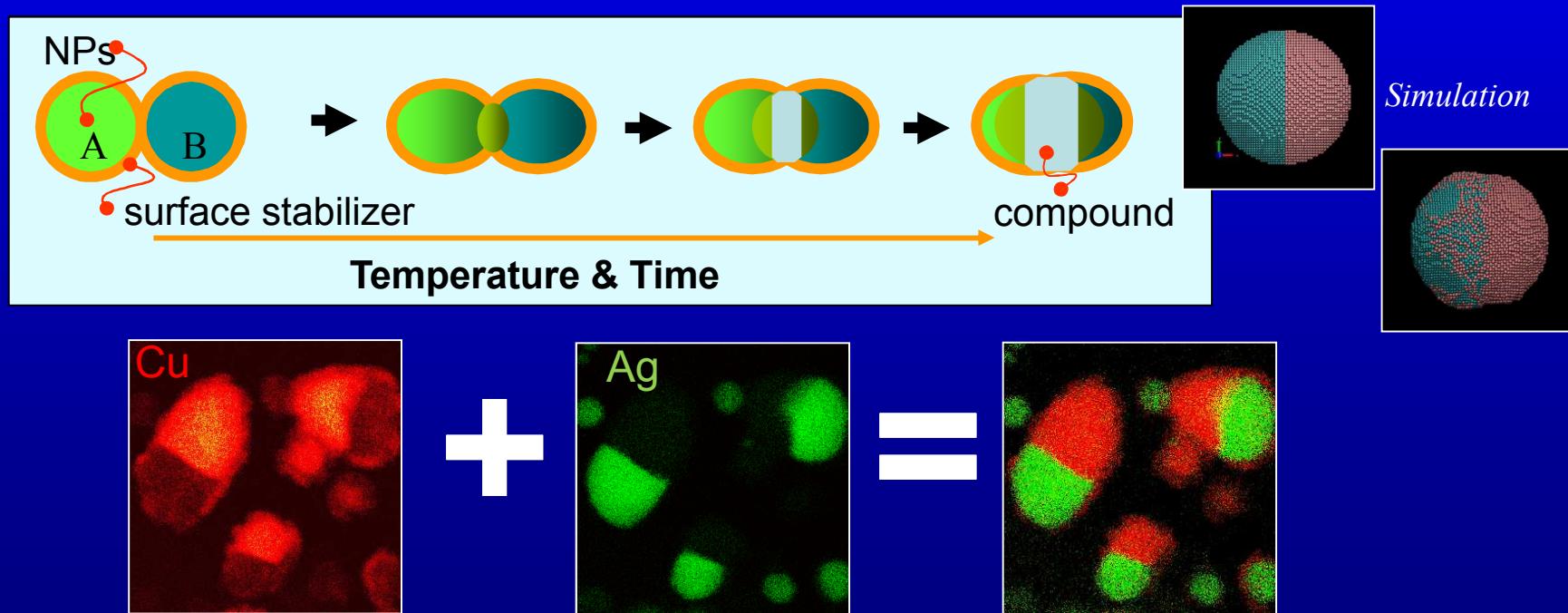
- ◆ A reverse transient liquid phase (TLP) process takes place whereby the Ge constituent is removed from the Ag-Au-Ge alloy.



- ◆ The consequences are:
 - **Binary alloy: 14.26Ag-85.74Au ... $T_s = T_l = 1055^\circ\text{C}$**
 - **Thick, brittle reaction layers formed at both interfaces.**

Nanoparticle Joining Technologies

- ◆ Much like TLP, nanoparticle joining offers this advantage:
 - A low temperature process is used to make a higher temperature interconnection.
- ◆ The objective is a methodology to deliver filler metal alloy nanoparticles to the faying surfaces and form a joint.

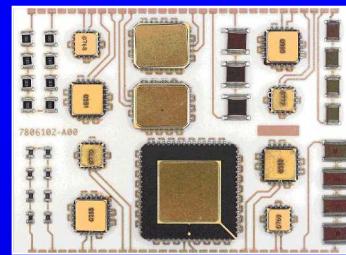


Global Perspective

- ◆ There are engineering challenges:

- **Materials**

- Interconnection materials
 - Base materials
 - Surface finishes

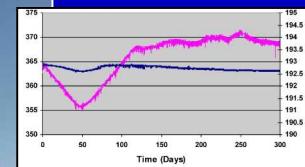
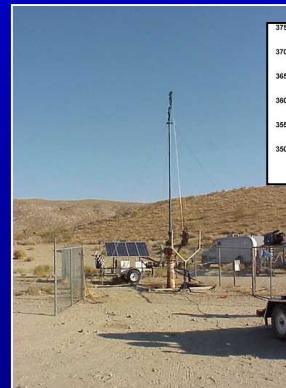


- **Manufacturing processes**

- Low to middle volumes
 - Fluxes or controlled atmospheres
 - Process windows/margins

- **Reliability testing**

- Test methods
 - Computational modeling
 - Field testing

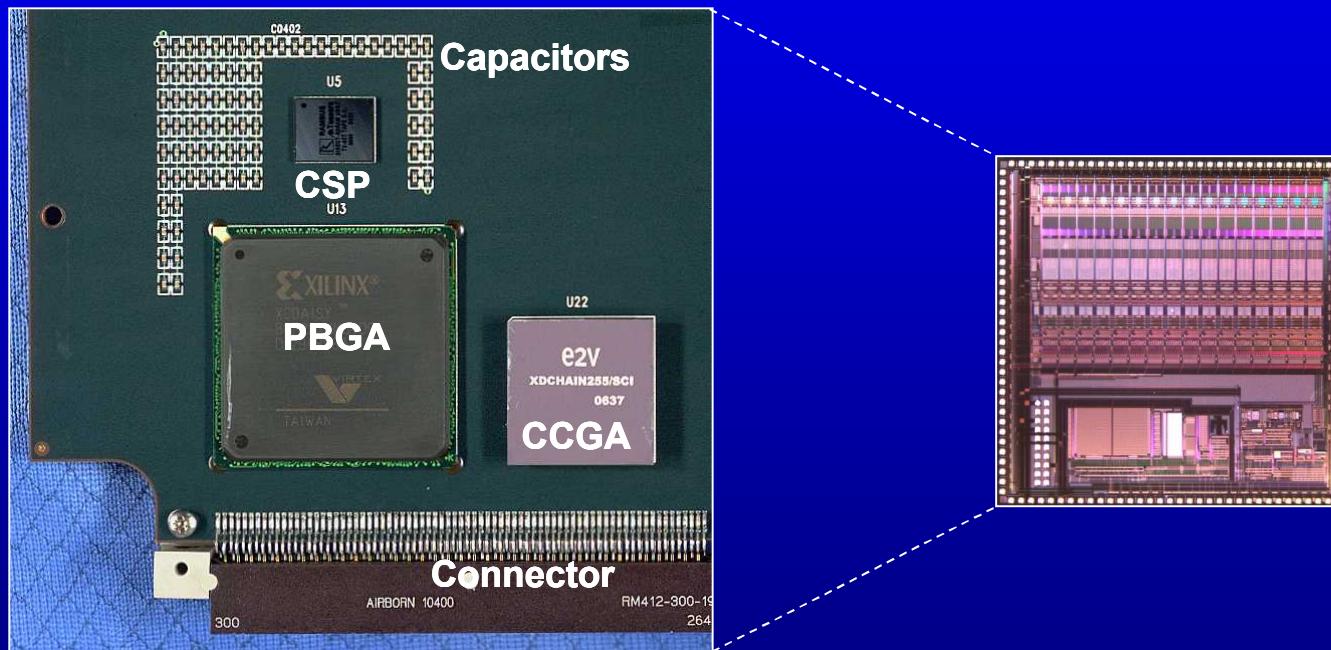


Courtesy of Sandia National Labs.

- ◆ In the long-run, an alternative interconnection technology must address cost and time-to-market as important considerations.

Global Perspective

- ◆ **Paradigm shift:** Accelerate integration methodologies such as System In a Package (SiP) technologies, to reduce or eliminate discrete components, connectors, etc. and thus, the number of interconnections required in the product.



Summary

- ◆ **Industry costs will continue to grow** that are needed to develop and sustain renewable and non-renewable energy resources.
- ◆ **High temperature electronics provide a cost-effective tool** for the exploration and sustainment of down-hole energy sources.
- ◆ **Besides the development of higher melting temperature filler metals, alternative interconnection technologies are being assessed that promise to increase operational margins as needed to accommodate down-hole environments.**



Courtesy of Dept. of Energy